

### CTC Laboratories, Inc.

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# TEST REPORT

Report No. .....: CTC20211141E

Applicant .....: XonTel Technology Trd. Co. W.L.L

Address...... Kuwait City, Qibla, Aladel Tower, F21, state of Kuwait .

Manufacturer...... XonTel Technology Trd. Co. W.L.L

Address...... Kuwait City, Qibla, Aladel Tower, F21, state of Kuwait .

 Product Name
 IP Phone

 Trade Mark
 XonTel

 Model/Type reference
 XT-07P

Listed Model(s) ...... /

Standard ...... EN 55032: 2015/AC: 2016

EN 55035: 2017 EN 61000-3-2: 2014 EN 61000-3-3: 2013

EN 55024: 2010+A1: 2015

Date of receipt of test sample......: Mar. 10, 2020

Date of testing...... Mar. 10, 2020 to Mar. 25, 2020

Date of issue...... Jul. 07, 2021

Result..... PASS

Compiled by:

(Printed name+signature) Jim Jiang

Jim ) iong

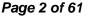
Supervised by:

( Printed name+signature) Eric Zhang

Approved by:

( Printed name+signature) Walter Chen

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### 1. TEST SUMMARY

#### 1.1. Test Standards

The tests were performed according to following standards:

EN 55032: 2015/AC: 2016—Electromagnetic compatibility of multimedia equipment—Emission Requirements

EN 55035: 2017-Electromagnetic compatibility of multimedia equipment-Immunity requirements

EN 61000-3-2: 2014—Electromagnetic compatibility (EMC) - Part 3-2: Limits - Limits for harmonic current emissions (equipment input current ≤ 16 A per phase)

<u>EN 61000-3-3: 2013</u>—Electromagnetic compatibility (EMC) - Part 3-3: Limits - Limitation of voltage changes, voltage fluctuations and flicker in public low-voltage supply systems, for equipment with rated current <= 16 A per phase and not subject to conditional connection

<u>EN 55024: 2010+A1: 2015</u>–Information technology equipment — Immunity characteristics — Limits and methods of measurement

## 1.2. Report version

Revised No.	Date of issue	Description
01	Apr. 13, 2020 Original	
02	Jul. 07, 2021	Add new applicant, manufacturer, trademark and product model based on the original report CTC20200296E01, do not affect the safety and electromagnetic compatibility performance.



## 1.3. Test Description

Emission						
Test Item	Standard requirement	Result	Test Engineer			
Radiated Emission (Below 1G)	EN 55032: 2015/AC:	Pass	Jon Huang			
Radiated Emission (Above 1G)		Pass	Jon Huang			
Conducted Emission(AC Mains)	2016	Pass	Jon Huang			
Conducted Emission(Signal Mains)		Pass	Jon Huang			
Harmonic Current Emissions	EN 61000-3-2: 2014	N/A	Note (2)			
Voltage Fluctuations and Flicker	EN 61000-3-3: 2013	Pass	Carl Wu			
	Immunity					
Test Item	Standard requirement	Result	Test Engineer			
Electrostatic Discharge		Pass	Carl Wu			
Radio Frequency Electromagnetic Field		Pass	Carl Wu			
Electrical Fast Transient / Burst		Pass	Carl Wu			
Surges	<b>5</b> 1,55005,0047	Pass	Carl Wu			
Injected Current	EN 55035: 2017 EN 55024: 2010+A1:	Pass	Carl Wu			
Power frequency magnetic fields	2015	N/A	Note (3)			
Voltage Dips and Interruptions		Pass	Carl Wu			
Broadband impulse noise disturbances, repetitive		N/A	Note (4)			
Broadband impulse noise disturbances, Isolated		N/A	Note (4)			

Note: (1) "N/A" is not applicable.

- (2) The power consumption of EUT is less than 75W and no Limits apply.
- (3) No magnetic sensitive components, so not applicable.
- (4) No analogue/digital XDSL port, so not applicable.
- (5) The measurement uncertainty is not included in the test result.

For anti-fake verification, please visit the official website of Certification and Accreditation Administration of the People's Republic of China: http://yz.cnca.cn

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### 1.4. Test Facility

CNAS-Lab Code: L5365

CTC Laboratories, Inc. has been assessed and proved to be in compliance with CNAS-CL01 Accreditation. Criteria for Testing and Calibration Laboratories (identical to ISO/IEC17025: 2005 General Requirements) for the Competence of Testing and Calibration Laboratories.

A2LA-Lab Cert. No.: 4340.01

CTC Laboratories, Inc. EMC Laboratory has been accredited by A2LA for technical competence in the field of electrical testing, and proved to be in compliance with ISO/IEC 17025: 2017 General Requirements for the Competence of Testing and Calibration Laboratories and any additional program requirements in the identified field of testing.

Industry Canada (Registration No.: 9783A, CAB Identifier: CN0029)

CTC Laboratories, Inc. EMC Laboratory has been registered by Certification and Engineer Bureau of Industry Canada for the performance of with Registration NO.: 9783A on Jan, 2016.

FCC (Registration No.: 951311, Designation Number CN1208)

CTC Laboratories, Inc. EMC Laboratory has been registered and fully described in a report filed with the (FCC) Federal Communications Commission. The acceptance letter from the FCC is maintained in our files. Registration 951311, Aug 26, 2017.

## 1.5. Measurement Uncertainty

The data and results referenced in this document are true and accurate. The reader is cautioned that there may be errors within the calibration limits of the equipment and facilities. The measurement uncertainty was calculated for all measurements listed in this test report acc. to TR-100028-01" Electromagnetic compatibility and Radio spectrum Matters (ERM);Uncertainties in the measurement of mobile radio equipment characteristics; Part 1" and TR-100028-02 "Electromagnetic compatibility and Radio spectrum Matters (ERM);Uncertainties in the measurement of mobile radio equipment characteristics; Part 2 " and is documented in the CTC Laboratories, Inc. quality system acc. to DIN EN ISO/IEC 17025. Furthermore, component and process variability of devices similar to that tested may result in additional deviation. The manufacturer has the sole responsibility of continued compliance of the device.

Below is the best measurement capability for CTC Laboratories, Inc.

CTC Laboratories, Inc.





#### A. Conducted Measurement:

Test Site	Method	Measurement Frequency Range	U (dB)	NOTE
C01	ANSI	150kHz~30MHz	3.2	/

#### B. Radiated Measurement:

	Test Site	Method	Measurement Frequency Range	U (dB)	NOTE
	C02	ANSI	30~1000MHz	3.5 dB	(1)
ſ	C02	ANSI	1~18GHz	5.1 dB	(1)

(1) This uncertainty represents an expanded uncertainty expressed at approximately the 95% confidence level using a coverage factor of k=2.

#### 1.6. Environmental conditions

During the measurement the environmental conditions were within the listed ranges:

Normal Temperature:	25 °C
Lative Humidity	55 %
Air Pressure	101 kPa

CTC Laboratories, Inc.





## 2. GENERAL INFORMATION

## 2.1. Client Information

Applicant:	XonTel Technology Trd. Co. W.L.L
Address:	Kuwait City, Qibla, Aladel Tower, F21, state of Kuwait .
Manufacturer:	XonTel Technology Trd. Co. W.L.L
Address:	Kuwait City, Qibla, Aladel Tower, F21, state of Kuwait .

## 2.2. General Description of EUT

Product Name:	IP Phone		
Trade Mark:	XonTel		
Model/Type reference:	XT-07P		
Listed Model(s):	/		
Model Difference:	/		
Power Supply :	5VDC 2A(Supply by external power adapter) 48VDC Ethernet (PoE) complied switch		
Hardware version:	N/A		
Software version:	N/A		
Remark:	The maximum operating frequency inside the EUT is 250MHz.		



2.3. Accessory Equipment information

Equipment Information						
Name	Manufacturer					
IP Phone	XT-07P		XonTel			
Switching Power Adaptor	F12W8-050200SPAV		FRECOM			
Switching Power Adaptor	F12W8-050200SPAB		FRECOM			
IP Phone	X7		/			
Ethernet Switch	H3C S1208-PWR	219801A0SYM17B0000LS	НЗС			
Ethernet Switch	DGS-1008P	QB842D1000045	D-Link			
Router	AC9		Tenda			
Cable Information						
Name	Shielded Type	Ferrite Core	Length			
Lan Cable	Unshielded	NO	1.5m			
DC Cable	Unshielded	NO	1.5m			





# 2.4. Description of Test Modes

Test mode	Description	
1	AC/DC Adapter + Telephony	
2	PoE + Telephony	

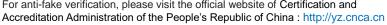
Test item	Test mode
Radiated Emission	1, 2
Conducted Emission(AC Mains)	1
Conducted Emission(Signal Mains)	1
Voltage Fluctuations and Flicker	1
Electrostatic Discharge	1, 2
Radio Frequency Electromagnetic Field	1, 2
Electrical Fast Transient / Burst	1
Surges	1
Injected Current	1
Voltage Dips and Interruptions	1





#### 2.5. Measurement Instruments List

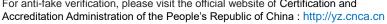
	Conducted Emission						
Item	Test Equipment	Manufacturer	Model No.	Serial No.	Calibrated until		
1	LISN	R&S	ENV216	101112	Dec. 27, 2020		
2	LISN	R&S	ENV216	101113	Dec. 27, 2020		
3	ISN CAT5	Schwarzbeck	NTFM8158	CAT5-8158-00 46	Dec. 27, 2020		
4	ISN CAT6	Schwarzbeck	NTFM8158	CAT6-8158-00 46	Dec. 27, 2020		
5	EMI Test Receiver	R&S	ESCI	100658	Dec. 27, 2020		
6	Current Probe	CYBERTEK	EM5011	E165011025	Dec. 27, 2020		
		Rad	liated Emission				
Item	Test Equipment	Manufacturer	Model No.	Serial No.	Calibrated until		
1	Trilog-Broadband Antenna	Schwarzbeck	VULB 9168	9168-1013	Dec. 27, 2020		
2	Horn Antenna	Schwarzbeck	BBHA 9120D	9120D-647	Dec. 27, 2020		
3	Spectrum Analyzer	R&S	FSU26	100105	Dec. 27, 2020		
4	Spectrum Analyzer	R&S	FSV40-N	101331	Dec. 27, 2020		
5	Pre-Amplifier	SONOMA	310	186194	Dec. 27, 2020		
6	Low Noise Pre-Amplifier	EMCI	EMC051835	980075	Dec. 27, 2020		
7	Test Receiver	R&S	ESCI7	100967	Dec. 27, 2020		
8	Antenna Mast	UC	UC3000	N/A	N/A		
9	Turn Table	UC	UC3000	N/A	N/A		
	Harmonio	Current Emission	ons &Voltage Fluct	uations and Flick	er		
Item	Test Equipment	Manufacturer	Model No.	Serial No.	Calibrated until		
1	Harmonic Flicker Analyzer	Voltech	PM6000	200006700723	Dec. 27, 2020		
2	Programmable AC Power Source	Mtoni	PHF1530	MTPS001	Dec. 27, 2020		
Power Disturbance							
Item	Test Equipment	Manufacturer	Model No.	Serial No.	Calibrated until		
1	EMI Test Receiver	R&S	ESCI	100658	Dec. 27, 2020		
2	Power Absorbing Clamp	R&S	MDS-21	100429	Dec. 27, 2020		
	Electrostatic Discharge						
Item	Test Equipment	Manufacturer	Model No.	Serial No.	Calibrated until		
1	ESD Simulator	EM TEST	DITO	V1113109156	Dec. 27, 2020		

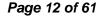




		RF Ele	ctromagnetic Field								
Item	Test Equipment	Manufacturer	Model No.	Serial No.	Calibrated until						
1	High Gain Log-Periodic Antenna	R&S	HL046E	100037	Dec. 27, 2020						
2	Stacked LogPer. Antenna	Schwarzbeck	STLP 9149	9149-658	Dec. 27, 2020						
3	Power Amplifier	BONN ELEKTRONIK	BLWA0830-160/10 0/40D	76788	Dec. 27, 2020						
4	Power Amplifier	Micotop	MPA-3-6G-50	MPA1706258	Dec. 27, 2020						
5	PSG Analog Signal Generator	Agilent	E8257D	MY46521908	Dec. 27, 2020						
6	Turn Table	UC	UC3000	N/A	N/A						
		Fast Trans	sients Common Mode	Э							
Item	Test Equipment	Manufacturer	Model No.	Serial No.	Calibrated until						
1	Electrical fast transient generator	3ctest	EFT-4003G	EC0471140	Dec. 27, 2020						
2	Coupling/Decoupling Clamp	3ctest	EFTC	EC0441141	Dec. 27, 2020						
Surges											
Item	Test Equipment	Manufacturer	Model No.	Serial No.	Calibrated until						
1	Surge generator	3ctest	SG-5006G	EC5581149	Dec. 27, 2020						
2	Surge CDN	3ctest	SGN-20G	EC5551128	Dec. 27, 2020						
3	Network Surge Generator	3ctest	CWS 600T	ES0311603	Dec. 27, 2020						
4	Network Surge CDN	3ctest	CDN 405T8A1	ES2731605	Dec. 27, 2020						
		RF	Common Mode								
Item	Test Equipment	Manufacturer	Model No.	Serial No.	Calibrated until						
1	C/S Generator	SCHLODER	CDG6000	126A1266	Dec. 27, 2020						
2	Coupling/Decoupling Network	SCHLODER	CDN M2+3	A2210258	Dec. 27, 2020						
3	Coupling/Decoupling Network	TESEQ GmbH	CDN T8-10	45011	Dec. 27, 2020						
4	6dB Attenuator	N/A	100W/6dB	N/A	Dec. 27, 2020						
		Power Fre	quency Magnetic Fie	ld							
Item	Test Equipment	Manufacturer	Model No.	Serial No.	Calibrated until						
1	Power Frequency Magnetic Field Generator	3ctest	PFMF-1200G	EC0111101	Dec. 27, 2020						
		Voltage o	lips and interruptions								
Item	Test Equipment	Manufacturer	Model No.	Serial No.	Calibrated until						
1	Voltage dips and up generator	3ctest	VDG-1105G	EC0171116	Dec. 27, 2020						

Note: The Cal. Interval was one year.







## 3. EMC EMISSION TEST

#### 3.1. Radiated Emission

#### **LIMIT**

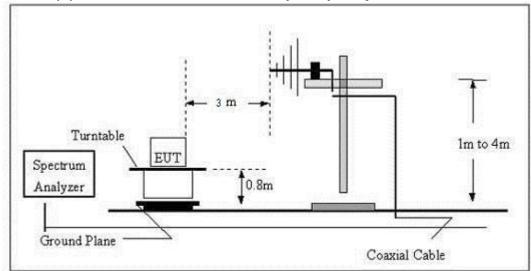
Please refer to CENELEC EN 55032 Annex A Table A.4 & A.5.

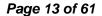
Frequency range (MHz)	Quasi-peak limits dBµV/m@3m	Quasi-peak limits dBµV/m@10m				
30~230	40	30				
230~1000	47	37				

Frequency range (GHz)	Average limits dBµV/m@3m	Peak limits dBµV/m@3m				
1 ~ 3	50	70				
3 ~ 6	54	74				

#### **TEST CONFIGURATION**

#### (A) Radiated Emission Test Set-Up Frequency below 1 GHz

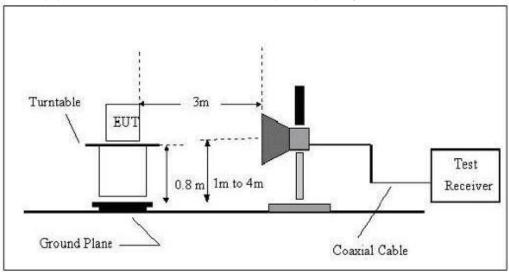






#### (B) Radiated Emission Test Set-Up Frequency above 1GHz

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#### **TEST PROCEDURE**

Please refer to CENELEC EN 55032 Clause 6.3 for the measurement methods.

The maximum operating frequency inside the EUT is 250MHz, and the radiated emission test is tested to 6GHz.

#### **TEST MODE**

Please refer to the Clause 2.3

#### **TEST RESULTS**

CTC Laboratories, Inc.

For anti-fake verification, please visit the official website of Certification and Accreditation Administration of the People's Republic of China: http://yz.cnca.cn

600 700

1000.000



#### (1) Below 1GHz

Test Mode	3		1						
Polarization	on		Horiz	Horizontal 230V 50Hz					
Test Volta	ge		230V						
90.0	dBuV/m								
-									
						N55032 Clas	s B 3m		
40								Margir	n-6 dB
10							_	6	
				3	1	4	5 X	ě K	

No.	Frequency (MHz)	Factor (dB/m)	Reading (dBuV)	Level (dBuV/m)	Limit (dBuV/m)	Margin (dB)	Detector
1	142.3243	-17.44	40.20	22.76	40.00	-17.24	QP
2	157.0072	-17.38	40.40	23.02	40.00	-16.98	QP
3	250.3010	-19.11	43.91	24.80	47.00	-22.20	QP
4	451.1349	-14.48	41.84	27.36	47.00	-19.64	QP
5	562.6622	-12.81	42.28	29.47	47.00	-17.53	QP
6	651.9416	-11.46	41.88	30.42	47.00	-16.58	QP

(MHz)

#### Remark:

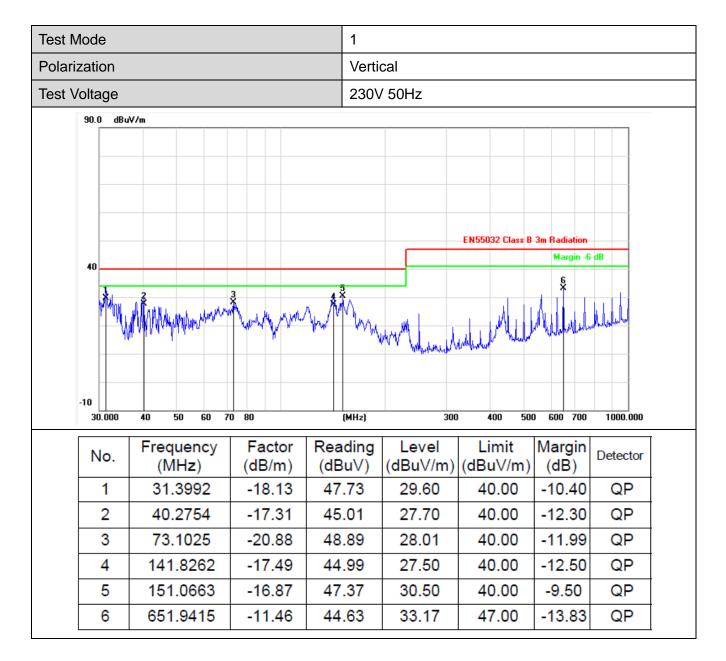
30.000

1. Factor (dB/m) = Antenna Factor (dB/m) + Cable Factor (dB) - Pre-amplifier Factor

70 80

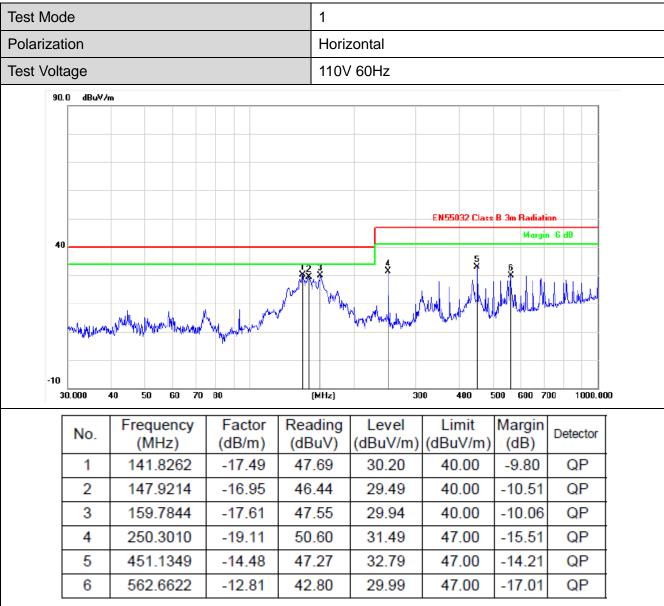
2. Margin value = Level - Limit value





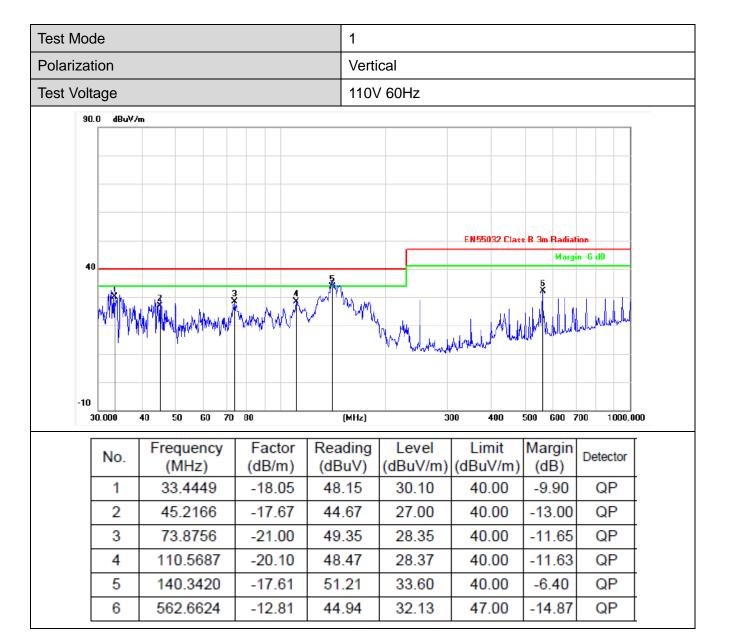
- 1. Factor (dB/m) = Antenna Factor (dB/m) + Cable Factor (dB) Pre-amplifier Factor
- 2. Margin value = Level Limit value

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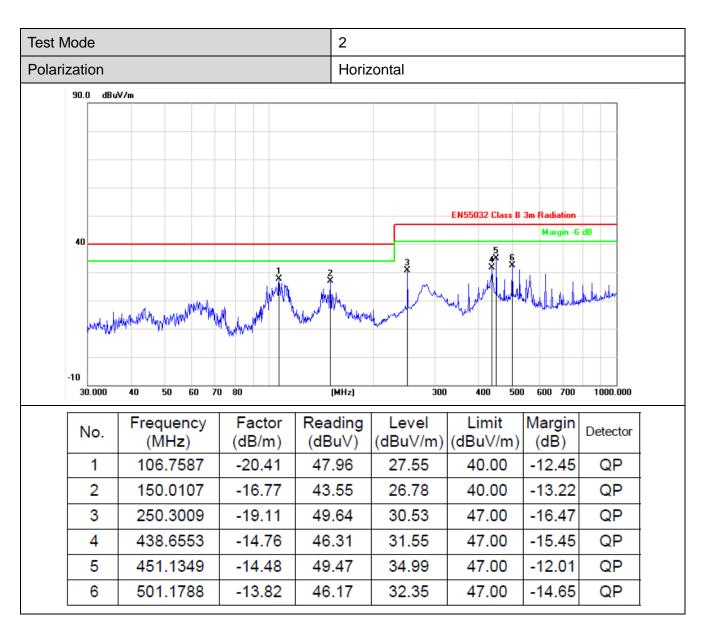
- 1. Factor (dB/m) = Antenna Factor (dB/m) + Cable Factor (dB) Pre-amplifier Factor
- 2. Margin value = Level Limit value



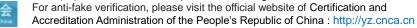


- 1. Factor (dB/m) = Antenna Factor (dB/m) + Cable Factor (dB) Pre-amplifier Factor
- 2. Margin value = Level Limit value

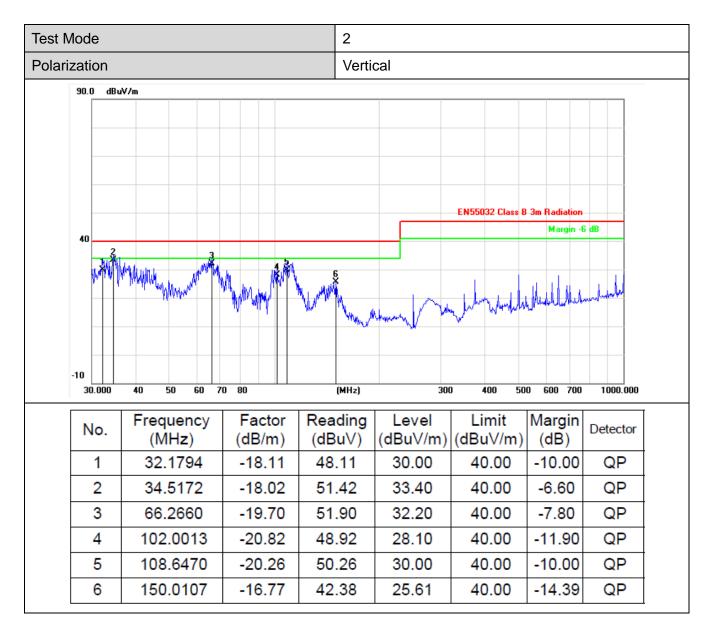




- 1. Factor (dB/m) = Antenna Factor (dB/m) + Cable Factor (dB) Pre-amplifier Factor
- 2. Margin value = Level Limit value



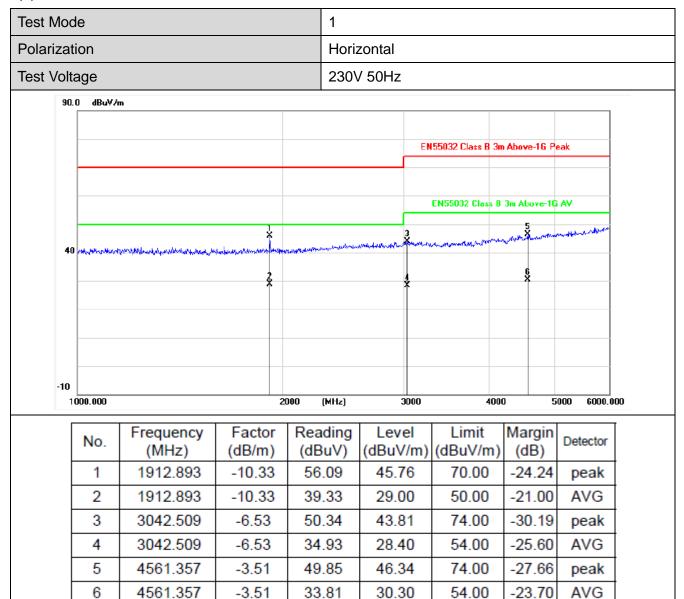




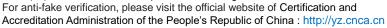
- 1. Factor (dB/m) = Antenna Factor (dB/m) + Cable Factor (dB) Pre-amplifier Factor
- 2. Margin value = Level Limit value



(2) Above 1GHz

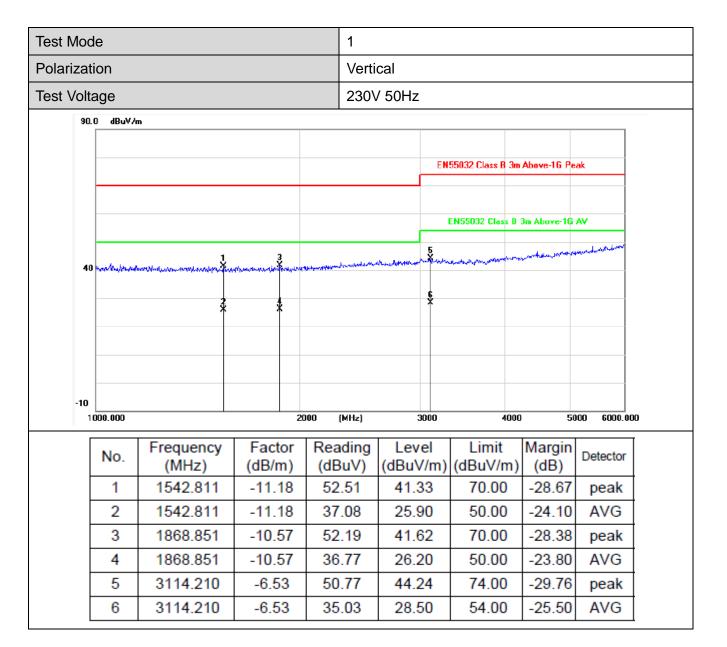


- 1. Factor (dB/m) = Antenna Factor (dB/m) + Cable Factor (dB) Pre-amplifier Factor
- 2. Margin value = Level Limit value



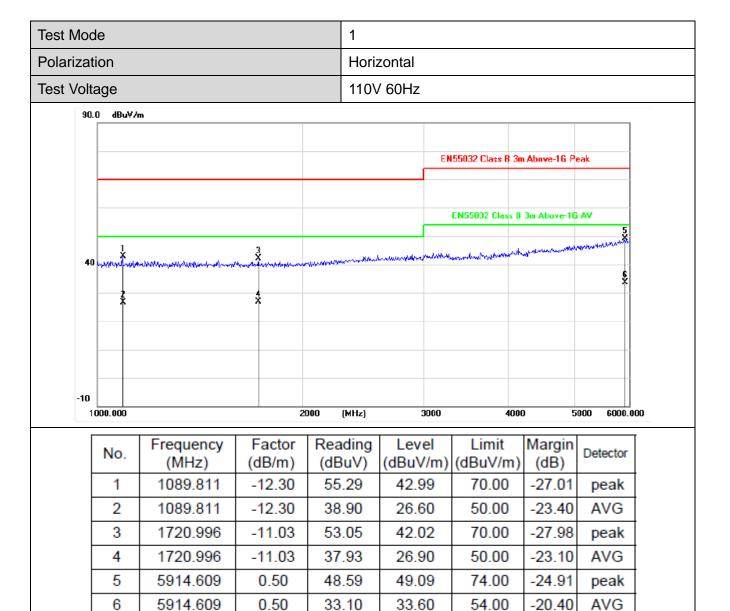






- 1. Factor (dB/m) = Antenna Factor (dB/m) + Cable Factor (dB) Pre-amplifier Factor
- 2. Margin value = Level Limit value





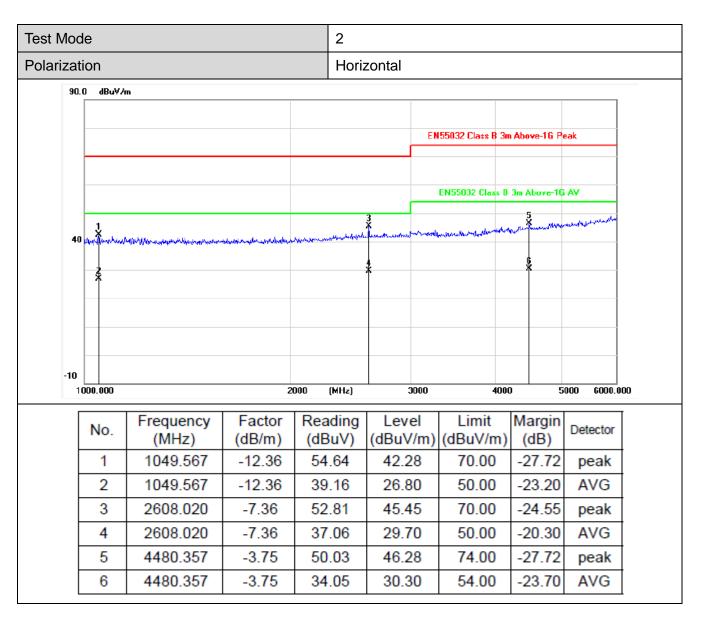
- 1. Factor (dB/m) = Antenna Factor (dB/m) + Cable Factor (dB) Pre-amplifier Factor
- 2. Margin value = Level Limit value



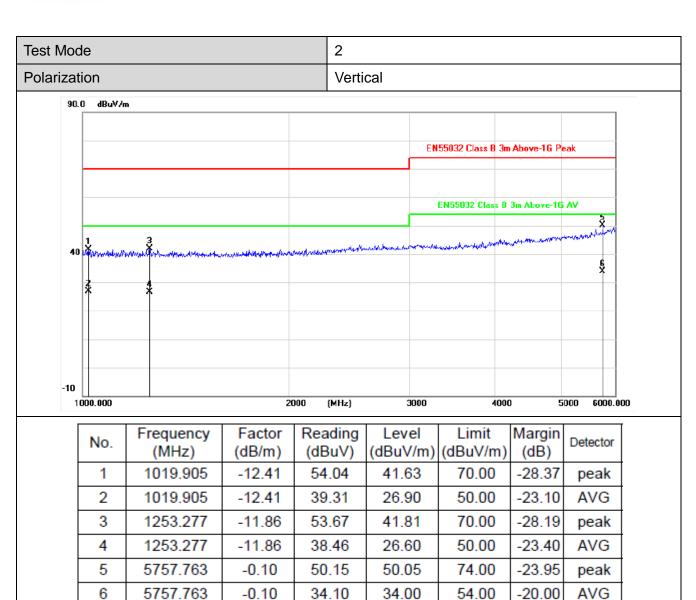
Test Mode 1 Polarization Vertical 110V 60Hz Test Voltage 90.0 dBuV/m EN55032 Class B 3m Above-1G Peak EN55032 Class B 3m Above-1G AV 1000.000 2000 (MHz) 3000 4000 5000 6000.000 Frequency Factor Reading Level Limit Margin No. Detector (MHz) (dB/m) (dBuV) (dBuV/m) (dBuV/m) (dB) 1 1049.567 54.23 41.87 70.00 -28.13 -12.36peak 2 1049.567 -12.3638.16 25.80 50.00 -24.20AVG 3 1625.096 -11.16 52.67 41.51 70.00 -28.49peak 4 1625.096 37.26 26.10 -23.90AVG -11.1650.00 -25.32 5 5675.819 -0.4249.10 48.68 74.00 peak AVG 6 5675.819 -0.42 32.72 32.30 54.00 -21.70

- 1. Factor (dB/m) = Antenna Factor (dB/m) + Cable Factor (dB) Pre-amplifier Factor
- 2. Margin value = Level Limit value





- 1. Factor (dB/m) = Antenna Factor (dB/m) + Cable Factor (dB) Pre-amplifier Factor
- 2. Margin value = Level Limit value



#### Remark:

- 1. Factor (dB/m) = Antenna Factor (dB/m) + Cable Factor (dB) Pre-amplifier Factor
- 2. Margin value = Level Limit value

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## 3.2. Conducted Emission (AC Mains)

#### LIMIT

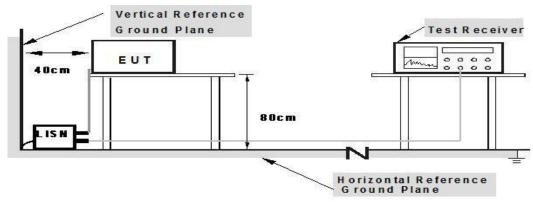
Please refer to CENELEC EN 55032 Annex A3 Table A.10.

Frequency range MHz	<b>Limits</b> dB(μV)						
IVII IZ	Quasi-peak	Average					
0,15 to 0,50	66 to 56	56 to 46					
0,50 to 5	56	46					
5 to 30	60	50					

NOTE 1 The lower limit shall apply at the transition frequencies.

NOTE 2 The limit decreases linearly with the logarithm of the frequency in the range 0,15 MHz to 0,50 MHz.

#### **TEST CONFIGURATION**



Note: 1.Support units were connected to second LISM.

2.Both of LISMs (AMM) are 80 cm from EUT and at least 80 from other units and other metal planes

#### **TEST PROCEDURE**

Please refer to CENELEC EN 55032 Annex A3 Table A.8.

#### **TEST MODE**

Please refer to the Clause 2.3

#### **TEST RESULTS**

Note:

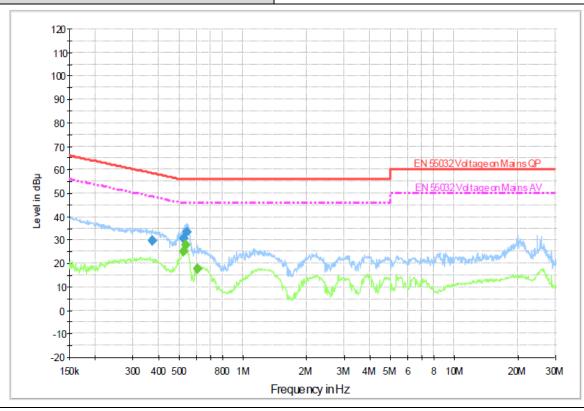
Factor = Insertion loss of LISN + Cable Loss

Limit = Limit stated in standard

Margin = Limit (dBuV) - Result (dBuV)



Test Mode	1
Polarization	L
Test Voltage	230V 50Hz



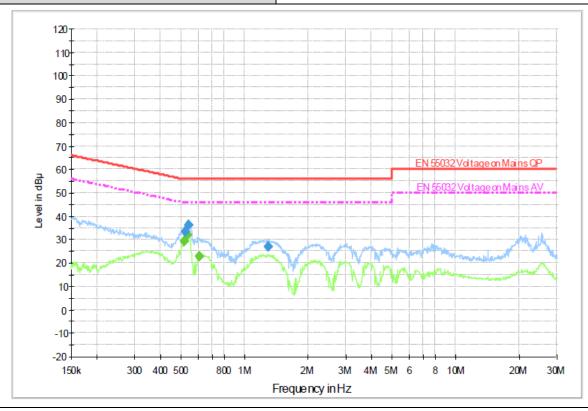
	Frequency (MHz)	QuasiPeak (dBµ V)	Meas. Time (ms)	Bandwidth (kHz)	Filter	Line	Corr. (dB)	Margin (dB)	Limit (dBµ V)	Comment
Г	0.372720	29.9	1000.00	9.000	On	L1	9.4	28.5	58.4	
	0.519130	30.7	1000.00	9.000	On	L1	9.4	25.3	56.0	
	0.540270	33.6	1000.00	9.000	On	L1	9.4	22.4	56.0	

Frequency (MHz)	Average (dBµ V)	Meas. Time (ms)	Bandwidth (kHz)	Filter	Line	Corr. (dB)	Margin (dB)	Limit (dBµ V)	Comment
0.519130	25.3	1000.00	9.000	On	L1	9.4	20.7	46.0	
0.535980	27.9	1000.00	9.000	On	L1	9.4	18.1	46.0	
0.609010	17.7	1000.00	9.000	On	L1	9.4	28.3	46.0	





Test Mode	1
Polarization	N
Test Voltage	230V 50Hz

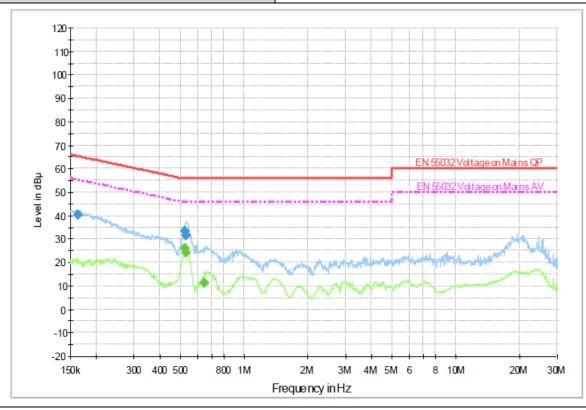


Frequenc (MHz)	y QuasiPeak (dBµ V)	Meas. Time (ms)	Bandwidth (kHz)	Filter	Line	Corr. (dB)	Margin (dB)	Limit (dBµ V)	Comment
0.51913	33.5	1000.00	9.000	On	N	9.4	22.5	56.0	
0.5402	70 36.0	1000.00	9.000	On	N	9.4	20.0	56.0	
1.28478	30 26.9	1000.00	9.000	On	N	9.5	29.1	56.0	

	Frequency (MHz)	Average (dBµ V)	Meas. Time (ms)	Bandwidth (kHz)	Filter	Line	Corr. (dB)	Margin (dB)	Limit (dBµ V)	Comment
ı	0.517060	29.5	1000.00	9.000	On	N	9.4	16.5	46.0	
	0.535980	32.1	1000.00	9.000	On	N	9.4	13.9	46.0	
	0.609010	22.6	1000.00	9.000	On	N	9.4	23.4	46.0	

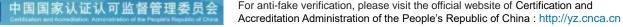


Test Mode	1
Polarization	L
Test Voltage	110V 60Hz



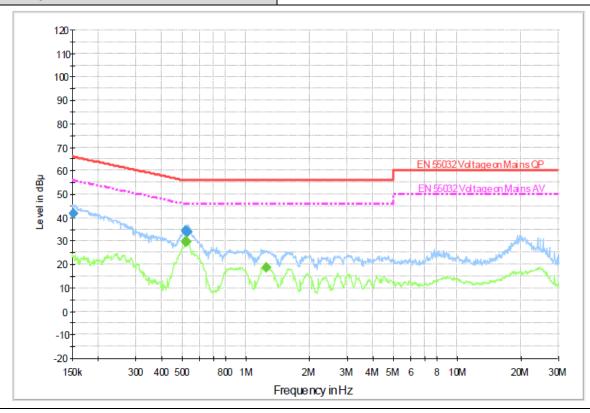
	Frequency (MHz)	QuasiPeak (dBµ V)	Meas. Time (ms)	Bandwidth (kHz)	Filter	Line	Corr. (dB)	Margin (dB)	Limit (dBµ V)	Comment
Г	0.163120	40.4	1000.00	9.000	On	L1	9.4	24.9	65.3	
	0.519130	33.4	1000.00	9.000	On	L1	9.4	22.6	56.0	
	0.529600	31.5	1000.00	9.000	On	L1	9.4	24.5	56.0	

Frequency (MHz)	Average (dBµ V)	Meas. Time (ms)	Bandwidth (kHz)	Filter	Line	Corr. (dB)	Margin (dB)	Limit (dBµ V)	Comment
0.519130	25.9	1000.00	9.000	On	L1	9.4	20.1	46.0	
0.527490	24.3	1000.00	9.000	On	L1	9.4	21.7	46.0	
0.646590	11.5	1000.00	9.000	On	L1	9.4	34.5	46.0	





Test Mode	1
Polarization	N
Test Voltage	110V 60Hz



Frequency (MHz)	QuasiPeak (dBµ V)	Meas. Time (ms)	Bandwidth (kHz)	Filter	Line	Corr. (dB)	Margin (dB)	Limit (dBµ V)	Comment
0.152410	41.7	1000.00	9.000	On	N	9.4	24.2	65.9	
0.517060	34.3	1000.00	9.000	On	N	9.4	21.7	56.0	
0.525380	33.8	1000.00	9.000	On	N	9.4	22.2	56.0	

	Frequency (MHz)	Average (dBµ V)	Meas. Time (ms)	Bandwidth (kHz)	Filter	Line	Corr. (dB)	Margin (dB)	Limit (dBµ V)	Comment
	0.517060	29.7	1000.00	9.000	On	N	9.4	16.3	46.0	
Г	0.523290	29.7	1000.00	9.000	On	N	9.4	16.3	46.0	
	1.249380	18.8	1000.00	9.000	On	N	9.5	27.2	46.0	



## 3.3. Conducted Emission (Signal Mains)

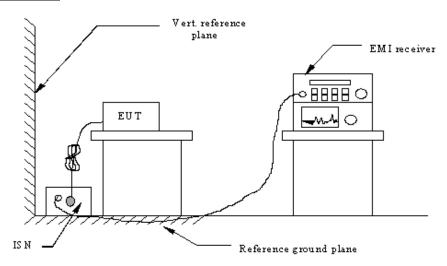
#### **LIMIT**

Please refer to CENELEC EN 55032 Annex A Table A.12.

Frequency range	Voltage Limi	ts dB(μV)	Current limits dB(μA)			
(MHz)	Quasi-peak	Average	Quasi-peak	Average		
0.15 ~ 0.5	84 ~ 74	74 ~ 64	40 ~ 30	30 ~ 20		
0.5 ~ 30	74	64	30	20		

**Note:** if "150 $\Omega$  to 50 $\Omega$  adaptor" applied, correction factor of 9.5dB should be added to the test data.

#### **TEST CONFIGURATION**



#### **TEST PROCEDURE**

Please refer to CENELEC EN 55032 section C4.

#### **TEST MODE**

Please refer to the Clause 2.3

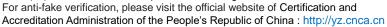
#### **TEST RESULTS**

Note:

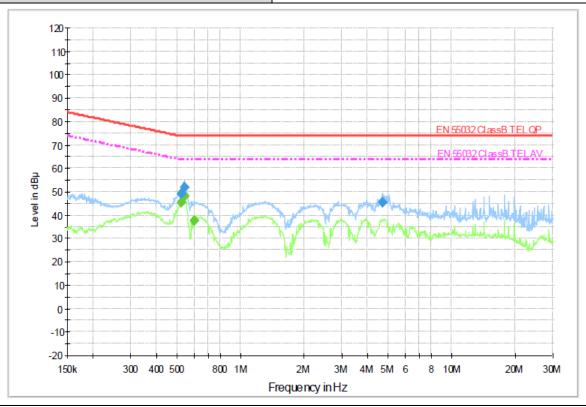
Factor = Insertion loss of LISN + Cable Loss

Limit = Limit stated in standard

Margin = Limit (dBuV) – Result (dBuV)







Frequency (MHz)	QuasiPeak (dBµ V)	Meas. Time (ms)	Bandwidth (kHz)	Filter	Line	Corr. (dB)	Margin (dB)	Limit (dBµ V)	Comment
0.519130	48.9	1000.00	9.000	On	N	9.4	25.1	74.0	
0.540270	51.9	1000.00	9.000	On	N	9.4	22.1	74.0	
4.664640	45.5	1000.00	9.000	On	N	9.5	28.5	74.0	

Frequency (MHz)	Average (dBµ V)	Meas. Time (ms)	Bandwidth (kHz)	Filter	Line	Corr. (dB)	Margin (dB)	Limit (dBµ V)	Comment
0.519130	45.4	1000.00	9.000	On	N	9.4	18.6	64.0	
0.540270	48.1	1000.00	9.000	On	N	9.4	15.9	64.0	
0.601760	37.8	1000.00	9.000	On	N	9.4	26.2	64.0	



## 3.4. Harmonic Current Emission

#### **LIMIT**

EN61000-3-2 Clause 7

#### Class A equipment

Harmonic order	Maximum permissible harmonic current		
n	A		
Odd har	monics		
3	2,30		
5	1,14		
7	0,77		
9	0,40		
11	0,33		
13	0,21		
15 ≤ n ≤ 39	0,15 1 <u>5</u>		
Even har	monics		
2	1,08		
4	0,43		
6	0,30		
8 ≤ n ≤ 40	0,23 <u>8</u>		

#### > Class B equipment

not exceed the values givenin Class A limit multiplied by a factor of 1,5

#### > Class C equipment

Active input power >25 W

Harmonic order	Maximum permissible harmonic currrent expressed as a percentage of the input current at the fundamental frequency
n	%
2	2
3	30 · λ *
5	10
7	7
9	5
11 ≤ n ≤ 39	3
(odd harmonics only)	
* $\lambda$ is the circuit power factor	

#### Active input power ≤25 W

Harmonic order	Maximum permissible harmonic current	Maximum permissible harmonic current
n	per watt mA/W	А
3	3,4	2,30
5	1,9	1,14
7	1,0	0,77
9	0,5	0,40
11	0,35	0,33
$13 \le n \le 39$ (odd harmonics only)	3,85 n	See Table 1



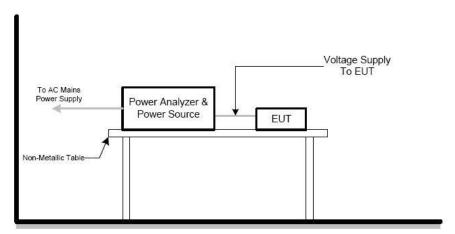
Or the third harmonic current, expressed as a percentage of the fundamental current, shall not exceed 86 % and the fifth harmonic current shall not exceed 61 %. Also, the waveform of the input current shall be such that it reaches the 5 % current threshold before or at 60°, has its peak value before or at 65° and does not fall below the 5 %current threshold before 90°, referenced to any zero crossing of the fundamental supply voltage. The current threshold is 5 % of the highest absolute peak value that occurs in the measurement window, and the phase angle measurements are made on the cycle that includes this absolute peak value.

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#### **Class D equipment**

Harmonic order	Maximum permissible harmonic current	Maximum permissible harmonic current
n	per watt mA/W	А
3	3,4	2,30
5	1,9	1,14
7	1,0	0,77
9	0,5	0,40
11	0,35	0,33
$13 \le n \le 39$ (odd harmonics only)	3,85 n	See Table 1

#### **TEST CONFIGURATION**



#### **TEST PROCEDURE**

Please refer to EN61000-3-2 for the measurement methods.

#### **TEST MODE**

Please refer to the Clause 2.3

#### **TEST RESULTS**

Note: The power of the EUT is less than 75W, So this test item is not applicable.

For anti-fake verification, please visit the official website of Certification and Accreditation Administration of the People's Republic of China: http://yz.cnca.cn





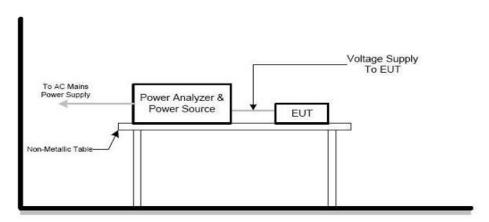
# 3.5. Voltage Fluctuation and Flicker

#### **LIMIT**

Please refer to EN61000-3-3

Tests	Li	mits	Descriptions
16212	IEC555-3	IEC/EN 61000-3-3	Descriptions
Pst	≤ 1.0, Tp= 10 min.	≤ 1.0, Tp= 10 min.	Short Term Flicker Indicator
Plt	N/A	≤ 0.65, Tp=2 hr.	Long Term Flicker Indicator
dc	≤ 3%	≤ 3.3%	Relative Steady-State V-Chang
dmax	≤ 4%	≤ 4%	Maximum Relative V-change
d (t)	N/A	≤ 3.3% for > 500 ms	Relative V-change characteristic

#### **TEST CONFIGURATION**

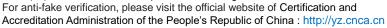


#### **TEST PROCEDURE**

Please refer to EN61000-3-3 for the measurement methods.

#### **TEST MODE**

Please refer to the Clause 2.3





**TEST RESULTS** 

Voltech IEC61000-3         Windows Software         1.27.13         Test Date:         23 Mar 2020         14:15           Type of Test:         Flickermeter Test - Table (EN61000-3-3:2013)           Power Analyzer:         Voltech PM6000 SN: 200006700723 Firmware Version: v1.22.07RC6 Channel(s):           1. SN: 090015502565, 28 Adjusted Date: 2 AUG 2013.         2. SN: 090015500533, 28 Adjusted Date: 19 MAR 2010.           3. SN: 090015502345, 28 Adjusted Date: 21 JUN 2012.         4. SN:None Adjusted Date: None           5. SN:None Adjusted Date: None Adjusted Date: None Shunt(s):         1. SN: 091024303183, 4 Adjusted Date: 8 AUG 2013.         2. SN: 091024302146, 4 Adjusted Date: 22 JUN 2012.           3. SN: 091024302144, 4 Adjusted Date: None Adjuste	Mode		1				
Power Analyzer: Voltech PM6000 SN: 200006700723 Firmware Version: v1.22.07RC6 Channel(s):  1. SN: 090015502565, 28 Adjusted Date: 2 AUG 2013. 2. SN: 090015500533, 28 Adjusted Date: 19 MAR 2010.  3. SN: 090015502345, 28 Adjusted Date: 21 JUN 2012. 4. SN:None Adjusted Date: None 5. SN:None Adjusted Date:None Adjusted Date:None Shunt(s):  1. SN: 091024303183, 4 Adjusted Date: 8 AUG 2013. 2. SN: 091024302146, 4 Adjusted Date: 22 JUN 2012.  3. SN: 091024302144, 4 Adjusted Date: 22 JUN 2012. 4. SN:None Adjusted Date:None 5. SN:None Adjusted Date:None Adjusted Date:None AC Source: Mains / Manual Source  Notes: Measurement method - Voltage	Voltech IEC61000-	3 Windows Software 1.2	7.13	Test Date: 23	Mar 2020 14:15		
Channel(s):  1. SN: 090015502565, 28 Adjusted Date: 2 AUG 2013. 2. SN: 090015500533, 28 Adjusted Date: 19 MAR 2010.  3. SN: 090015502345, 28 Adjusted Date: 21 JUN 2012. 4. SN:None Adjusted Date: None  5. SN:None Adjusted Date: None Adjusted Date: None Shunt(s):  1. SN: 091024303183, 4 Adjusted Date: 8 AUG 2013. 2. SN: 091024302146, 4 Adjusted Date: 22 JUN 2012.  3. SN: 091024302144, 4 Adjusted Date: 22 JUN 2012. 4. SN:None Adjusted Date: None  5. SN:None Adjusted Date: None Adjusted Date: None  AC Source: Mains / Manual Source  Notes:  Measurement method - Voltage	Type of Test:	Flickermeter Test - Table (EN61000-3-3:2013)					
3. SN: 090015502345, 28 Adjusted Date: 21 JUN 2012. 4. SN:None Adjusted Date: None 5. SN:None Adjusted Date:None 6. SN:None Adjusted Date: None Shunt(s): 1. SN: 091024303183, 4 Adjusted Date: 8 AUG 2013. 2. SN: 091024302146, 4 Adjusted Date: 22 JUN 2012. 3. SN: 091024302144, 4 Adjusted Date: 22 JUN 2012. 4. SN:None Adjusted Date:None 5. SN:None Adjusted Date:None Adjusted Date:None AC Source: Mains / Manual Source  Overall Result: Notes: Measurement method - Voltage	Power Analyzer:						
5. SN:None Adjusted Date:None 6. SN:None Adjusted Date:None Shunt(s):  1. SN: 091024303183, 4 Adjusted Date: 8 AUG 2013. 2. SN: 091024302146, 4 Adjusted Date: 22 JUN 2012. 3. SN: 091024302144, 4 Adjusted Date: 22 JUN 2012. 4. SN:None Adjusted Date:None 5. SN:None Adjusted Date:None Adjusted Date:None AC Source: Mains / Manual Source  Overall Result: Notes: Measurement method - Voltage		1. SN: 090015502565, 28 Adjust	ed Date: 2 AUG 2013. 2. SN:	090015500533, 28 Adjusted Da	ate: 19 MAR 2010.		
Shunt(s):  1. SN: 091024303183, 4 Adjusted Date: 8 AUG 2013. 2. SN: 091024302146, 4 Adjusted Date: 22 JUN 2012. 3. SN: 091024302144, 4 Adjusted Date: 22 JUN 2012. 4. SN:None Adjusted Date:None 5. SN:None Adjusted Date:None Adjusted Date:None AC Source: Mains / Manual Source  Overall Result: Notes: Measurement method - Voltage		3. SN: 090015502345, 28 Adjust	3. SN: 090015502345, 28 Adjusted Date: 21 JUN 2012.				
1. SN: 091024303183, 4 Adjusted Date: 8 AUG 2013. 2. SN: 091024302146, 4 Adjusted Date: 22 JUN 2012. 3. SN: 091024302144, 4 Adjusted Date: 22 JUN 2012. 4. SN:None Adjusted Date:None 5. SN:None Adjusted Date:None Adjusted Date:None AC Source: Mains / Manual Source  Overall Result: Notes: Measurement method - Voltage		5. SN:None Adjusted Date:None 6. SN:None Adjusted Date:None					
3. SN: 091024302144, 4 Adjusted Date: 22 JUN 2012. 4. SN:None Adjusted Date:None 5. SN:None Adjusted Date:None Adjusted Date:None AC Source: Mains / Manual Source  Overall Result: Notes: Measurement method - Voltage	Shunt(s):						
5. SN:None Adjusted Date:None 6. SN:None Adjusted Date:None  AC Source: Mains / Manual Source  Overall Result: Notes: Measurement method - Voltage		1. SN: 091024303183, 4 Adjuste	d Date: 8 AUG 2013. 2. SN: 0	091024302146, 4 Adjusted Date:	22 JUN 2012.		
AC Source: Mains / Manual Source  Overall Result: Notes: Measurement method - Voltage		3. SN: 091024302144, 4 Adjusted Date: 22 JUN 2012. 4. SN:None Adjusted Date:None					
Overall Result: Notes:  Measurement method - Voltage		5. SN:None Adjusted Date:Non	e 6. SN:None Adjusted Date	:None			
Measurement method - Voltage	AC Source:	Mains / Manual Source					
			- Voltage				
		Pst	dc (%)	dmax (%)	Tmax(> 3.3%)(ms)		
Pst dc (%) dmax (%) Tmax(> 3.3%)(ms)	Limit	1.000	3.300	4.000	500		
	Reading 1	0.380	0.000	1.715	0		

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### 4. EMS IMMUNITY TEST

### Performance criteria

## General performance criteria

- Performance criteria A for immunity tests with phenomena of a continuous nature;
- Performance criteria B for immunity tests with phenomena of a transient nature;
- Performance criteria C for immunity tests with power interruptions exceeding a certain time.

The equipment shall meet the minimum performance criteria as specified in the following.

Criteria	During test	After test
A	Shall operate as intended.  May show degradation of performance (see note 1).  Shall be no loss of function.  Shall be no unintentional transmissions.	Shall operate as intended.  Shall be no degradation of performance (see note 2).  Shall be no loss of function.  Shall be no loss of stored data or user programmable functions.
В	May show loss of function (one or more).  May show degradation of per formance(see note 1).  No unintentional transmissions.	Functions shall be self-recoverable.  Shall operate as intended after recovering.  Shall be no degradation of performance (see note 2).  Shall be no loss of stored data or user programmable functions.
С	May be loss of function (one or more).	Functions shall be recoverable by the operator.  Shall operate as intended after recovering.  Shall be no degradation of performance (see note 2).

#### NOTE 1:

Degradation of performance during the test is understood as a degradation to a level not below a minimum performance level specified by the manufacturer for the use of the apparatus as intended. In some cases the specified minimum performance level may be replaced by a permissible degradation of performance.

If the minimum performance level or the permissible performance degradation is not specified by the manufacturer then either of these may be derived from the product description and documentation (including leaflets and advertising) and what the user may reasonably expect from the apparatus if used as intended.

#### NOTE 2:

No degradation of performance after the test is understood as no degradation below a minimum performance level specified by the manufacturer for the use of the apparatus as intended. In some cases the specified minimum performance level may be replaced by a permissible degradation of performance. After the test no change of actual operating data or user retrievable data is allowed.

If the minimum performance level or the permissible performance degradation is not specified by the manufacturer then either of these may be derived from the product description and documentation (including leaflets and advertising) and what the user may reasonably expect from the apparatus if used as intended.





## 4.1. Electrostatic Discharge

## **PERFORMANCE CRITERION**

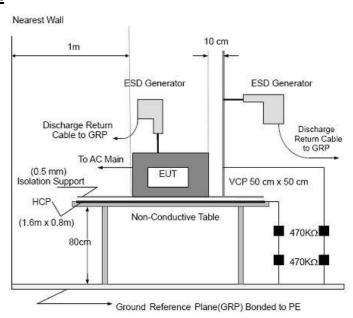
Standard	Criterion
EN 55035: 2017/EN 55024: 2010+A1: 2015	Criteria B

### **TEST LEVEL**

Contact Discharge at ±2kV, ±4kV

Air Discharge at ±2kV, ±4kV, ±8kV

### **TEST CONFIGURATION**



### **TEST PROCEDURE**

Please refer to EN 55035: 2017/EN 55024: 2010+A1: 2015 for the measurement methods.

#### **Contact Discharge:**

The ESD generator is held perpendicular to the surface to which the discharge is applied and the tip of the discharge electrode touch the surface of EUT. Then turn the discharge switch. The generator is then re-triggered for a new single discharge and repeated at least 10 times for each pre-selected test point. This procedure shall be repeated until all the air discharge completed.

#### Air Discharge:

Air discharge is used where contact discharge can't be applied. The round discharge tip of the discharge electrode shall be approached as fast as possible to touch the EUT. After each discharge, the discharge electrode shall be removed from the EUT. The generator is then re-triggered for a new single discharge and repeated at least 10 times for each pre-selected test point. This procedure shall be repeated until all the air discharge completed.

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## Indirect discharge for horizontal coupling plane:

At least 10 single discharges shall be applied to the horizontal coupling plane, at points on each side of the EUT.

## Indirect discharge for vertical coupling plane:

At least 10 single discharges shall be applied to the center of one vertical edge of the coupling plane. The coupling plane, of dimensions 0.5m X 0.5m, is placed parallel to, and positioned at a distance of 0.1m from the EUT. Discharges shall be applied to the coupling plane, with this plane in sufficient different positions that the four faces of the EUT are completely illuminated.

#### **TEST MODE**

Please refer to the Clause 2.3

## **TEST RESULTS**

Test mode		1, 2			
Temperature	25℃	Humidity	55%	Atmospheric pressure	101kPa
Туре	Type of discharge	Discharge voltage (kV)	Observations Performance	Criteria Level	Result
Direct	Contact	±2	Α	В	
	discharge	±4	В	В	
	Air discharge	±2	А	В	Pass
		±4	А	В	
		±8	В	В	
Indirect	НСР	±4	В	В	Pass
	VCP	±4	В	В	rdSS

Note: The ancillary equipment's specification for an acceptable level of performance or degradation of performance during and/or after the ESD tests.





# 4.2. Radio Frequency Electromagnetic Field

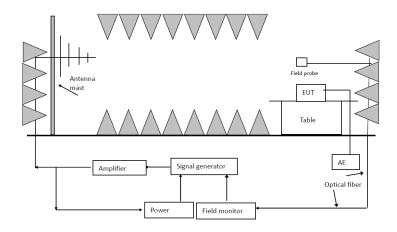
## **PERFORMANCE CRITERION**

Standard	Criterion
EN 55035: 2017/EN 55024: 2010+A1: 2015	Criteria A

### **TEST LEVEL**

Condition of Test	Remark	
Fielded strength	3V/m	
Radiated signal	Modulated	
Scanning frequency	80-1000MHz, 1800MHz, 2600MHz, 3500MHz, 5000MHz	
Sweep time of radiated	0.0015 Decade/s	
Dwell time	1 Sec.	

### **TEST CONFIGURATION**



### **TEST PROCEDURE**

Please refer to EN 61000-4-3 for the measurement methods.

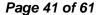
## **TEST MODE**

Please refer to the Clause 2.3

## **TEST RESULTS**

Test mode:	1, 2		
Antenna Polarity	Observations (Performance Criterion)	Criteria Level	Result
H/V	A	А	Pass

CTC Laboratories, Inc.





## 4.3. Fast Transients Common Mode

### PERFORMANCE CRITERION

Standard	Criterion
EN 55035: 2017/EN 55024: 2010+A1: 2015	Criteria B

### **TEST LEVEL**

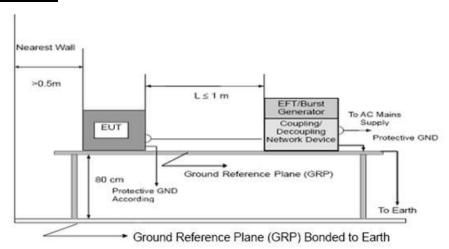
Level: 1KV for AC port, 0.5KV for signal port

Impulse Frequency: 5 kHz;

Tr/Td: 5/50ns;

Burst Duration: 15ms; Burst Period: 3Hz

## **TEST CONFIGURATION**



### **TEST PROCEDURE**

Please refer to EN 61000-4-4 for the measurement methods.

### **TEST MODE**

Please refer to the Clause 2.3

### **TEST RESULTS**

Test mode:		1		
Lead under Test	Coupling Direct / Clamp	Observations (Performance Criterion)	Criteria Level	Result
L, N, L+N	Direct	A	В	Pass
Signal Port	Direct	A	В	Pass





## 4.4. Surge

## **PERFORMANCE CRITERION**

Standard	Criterion
EN 55035: 2017/EN 55024: 2010+A1: 2015	Criteria B

### **TEST LEVEL**

Level: 1kV for line to line, 2kV for line to ground

Voltage Waveform: 1.2/50 us; Current Waveform: 8/20 us

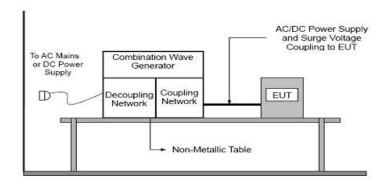
Pluse quantity: 5, interval time: 60 seconds

Phase: 0°, 90°, 180°, 270°

1KV for signal port

Voltage Waveform: 10/700 us

### **TEST CONFIGURATION**



## **TEST PROCEDURE**

Please refer to EN 61000-4-5 for the measurement methods.

### **TEST MODE**

Please refer to the Clause 2.3

## **TEST RESULTS**

Test mode:		1		
Lead under Test	Phase	Observations (Performance Criterion)	Criteria Level	Result
L - N	0°/90°/180°/270°	A	В	Pass
Signal Port	/	A	В	Pass



# 4.5. Radio frequency common mode

### PERFORMANCE CRITERION

Standard	Criterion
EN 55035: 2017/EN 55024: 2010+A1: 2015	Criteria A

## **TEST LEVEL**

Test frequency range: 150 kHz~80MHz

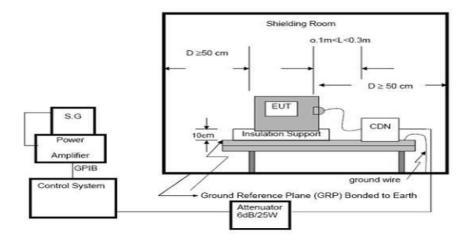
Level: 3Vrms

Modulation type: Amplitude Modulation, 80% depth Modulated signal: 1 kHz sinusoidal audio signal

Frequency increment step: 1%

Dwell time: 3 seconds

### **TEST CONFIGURATION**



## **TEST PROCEDURE**

Please refer to EN 61000-4-6 for the measurement methods.

### **TEST MODE**

Please refer to the Clause 2.3

### **TEST RESULTS**

Test mode:	1		
Injected Position	Observations (Performance Criterion)	Criteria Level	Result
AC Mains	A	А	Pass
Signal Port	A	А	Pass



## 4.6. Voltage dips and interruptions

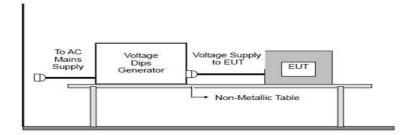
## **PERFORMANCE CRITERION**

Standard	Criterion	
EN 55035: 2017/EN 55024: 2010+A1: 2015	B (For 0% Voltage Dips)	
	C (For 70% Voltage Dips)	
	C (For 0% Voltage Interruptions)	

### **TEST LEVEL**

0% of VT (Supply Voltage) for 0.5 period 0% of VT (Supply Voltage) for 1 period 70% of VT (Supply Voltage) for 25 period 0% of VT (Supply Voltage) for 250 period Dip quantity: 3, interval time: 10 seconds

### **TEST CONFIGURATION**



## **TEST PROCEDURE**

Please refer to EN 61000-4-11 for the measurement methods.

### **TEST MODE**

Please refer to the Clause 2.3

### **TEST RESULTS**

Test mode:		1			
Test Voltage %	Duration periods	Phase angle	Observations (Performance Criterion)	Criteria Level	Result
0	0.5	0°, 45°, 90°, 135°, 180°, 225°, 270°, 315°	A	В	Pass
0	1		Α	В	Pass
70	25		A	С	Pass
0	250		С	С	Pass

Remark: During the test voltage interruption process, the EUT automatically shuts down and cannot be automatically restored, and can work normally after restarting.

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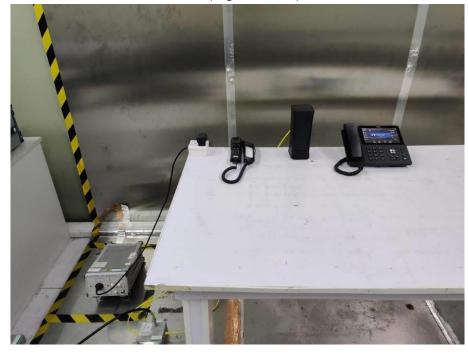


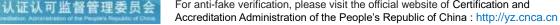
# 5. EUT TEST PHOTOS

## Conducted Emission (AC Mains) for Test mode 1



Conducted Emission (Signal Mains) for Test mode 1







Radiated Measurement (30MHz~1000MHz) for Test mode 1



Radiated Measurement (30MHz~1000MHz) for Test mode 2





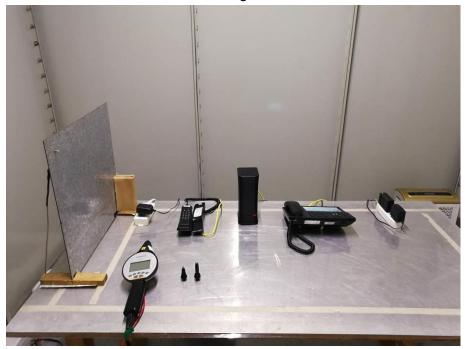




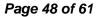
## Harmonic Current Emission/ Voltage Fluctuations & Flicker for Test mode 1



Electrostatic Discharge for Test mode 1

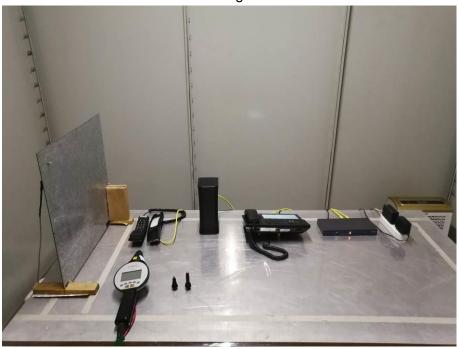




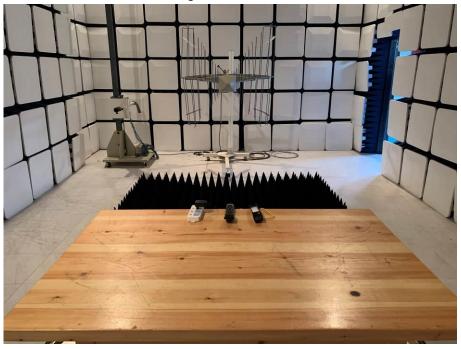




Electrostatic Discharge for Test mode 2

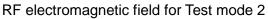


RF electromagnetic field for Test mode 1







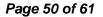




Electric Fast Transients(AC Mains) for Test mode 1









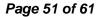
Electric Fast Transients(Signal Mains) for Test mode 1



Surges (AC Mains) for Test mode 1











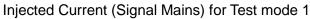


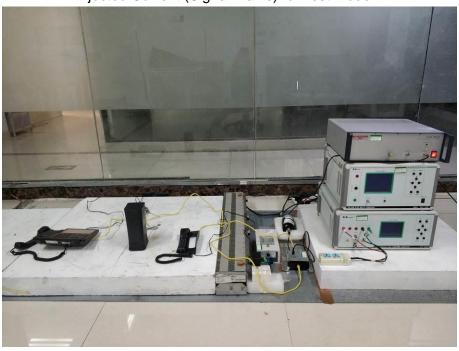
Injected Current (AC Mains) for Test mode 1



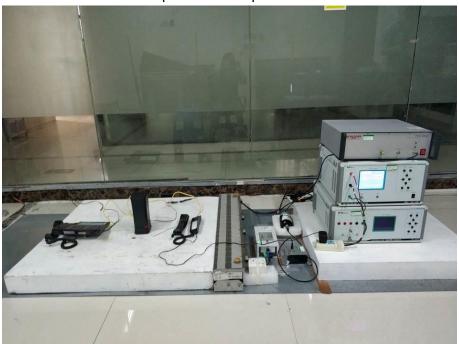


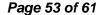






Volt. Interruptions/Volt. Dips for Test mode 1







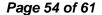
# 6. PHOTOGRAPHS OF EUT CONSTRUCTIONAL

## **External Photographs**







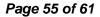


























Model:XT-07P







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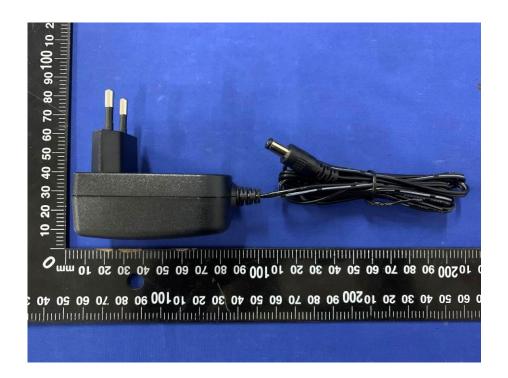
Input:5V === 2A or PoE 48V

Rev:A

Made in China

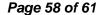
Designed By XonTel, State of Kuwait









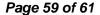














Internal Photographs

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